

SPICE Device Model Si3585DV Vishay Siliconix

N- and P-Channel 20-V (D-S) MOSFET

CHARACTERISTICS

- N- and P-Channel Vertical DMOS
- Macro Model (Subcircuit Model)
- Level 3 MOS

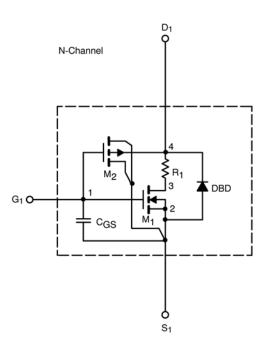
- · Apply for both Linear and Switching Application
- Accurate over the –55 to 125°C Temperature Range
- Model the Gate Charge, Transient, and Diode Reverse Recovery Characteristics

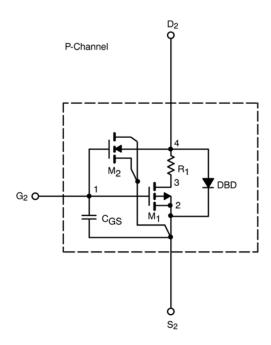
DESCRIPTION

The attached spice model describes the typical electrical characteristics of the n- and p-channel vertical DMOS. The subcircuit model is extracted and optimized over the -55 to $125\,^{\circ}\mathrm{C}$ temperature ranges under the pulsed 0-V to 5-V gate drive. The saturated output impedance is best fit at the gate bias near the threshold voltage.

A novel gate-to-drain feedback capacitance network is used to model the gate charge characteristics while avoiding convergence difficulties of the switched $C_{\rm gd}$ model. All model parameter values are optimized to provide a best fit to the measured electrical data and are not intended as an exact physical interpretation of the device.

SUBCIRCUIT MODEL SCHEMATIC





This document is intended as a SPICE modeling guideline and does not constitute a commercial product data sheet. Designers should refer to the appropriate data sheet of the same number for guaranteed specification limits.

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SPECIFICATIONS (T _J = 25°C	UNLESS OT	HERWISE NOTED)				
Parameter	Symbol	Test Condition		Simulated Data	Measured Data	Unit
Static						
Gate Threshold Voltage	V _{GS(th)}	V_{DS} = V_{GS} , I_D = 250 μA	N-Ch	1.1		V
		$V_{DS} = V_{GS}$, $I_D = -250 \mu A$	P-Ch	1.1		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \geq 5 \ V, \ V_{GS}$ = 4.5 V	N-Ch	19		А
		$V_{DS} \leq -5~V,~V_{GS}$ = $-~4.5~V$	P-Ch	14		
Drain-Source On-State Resistance ^a	Γ _{DS(on)}	V _{GS} = 4.5 V, I _D = 2.4 A	N-Ch	0.116	0.100	Ω
		$V_{GS} = -4.5 \text{ V}, I_D = -1.8 \text{ A}$	P-Ch	0.179	0.160	
		V _{GS} = 2.5 V, I _D = 1.8 A	N-Ch	0.153	0.160	
		$V_{GS} = -2.5 \text{ V}, I_D = -1.2 \text{ A}$	P-Ch	0.250	0.280	
Forward Transconductance ^a	g _{fs}	$V_{DS} = 5 \text{ V}, I_{D} = 2.4 \text{ A}$	N-Ch	5	5	S
		$V_{DS} = -5 \text{ V}, I_{D} = -1.8 \text{A}$	P-Ch	3.6	3.6	
Diode Forward Voltage ^a	V _{SD}	I _S = 1.05 A, V _{GS} = 0 V	N-Ch	0.79	0.80	V
		I _S = -1.05 A, V _{GS} = 0 V	P-Ch	-0.78	-0.83	
Dynamic ^b	-		-	•	-	=
Total Gate Charge	Q_g	N-Channel $V_{DS} = 10 \text{ V, } V_{GS} = 4.5 \text{ V, } I_D = 2.4 \text{ A}$ $P\text{-Channel}$ $V_{DS} = -10 \text{ V, } V_{GS} = -4.5 \text{ V, } I_D = -1.8 \text{ A}$	N-Ch	1.8	2.1	nC
			P-Ch	2.5	2.7	
Gate-Source Charge	Q_gs		N-Ch	0.3	0.3	
			P-Ch	0.4	0.4	
Gate-Drain Charge	Q_{gd}	$v_{DS} = -10 \text{ V}, v_{GS} = -4.3 \text{ V}, I_D = -1.6 \text{ A}$	N-Ch	0.4	0.4	
			P-Ch	0.6	0.6	
Turn-On Delay Time	t _{d(on)}	$ \begin{array}{c} \text{N-Ch} \\ \text{N-Channel} \\ \text{V}_{\text{DD}} = 10\text{V}, \text{R}_{\text{L}} = 10 \Omega \\ \text{I}_{\text{D}} \cong 1 \text{A}, \text{V}_{\text{GEN}} = 4.5 \text{V}, \text{R}_{\text{G}} = 6 \Omega \\ \text{P-Channel} \\ \text{V}_{\text{DD}} = -10 \text{V}, \text{R}_{\text{L}} = 10 \Omega \\ \text{I}_{\text{D}} \cong -1 \text{A}, \text{V}_{\text{GEN}} = -4.5 \text{V}, \text{R}_{\text{G}} = 6 \Omega \\ \end{array} \qquad \begin{array}{c} \text{N-Ch} \\ \text{P-Ch} \\ \text{N-Ch} \\ \end{array} $	N-Ch	10	10	
			P-Ch	10	11	
Rise Time	t _r		N-Ch	13	30	
			P-Ch	8	34	
Turn-Off Delay Time	$t_{d(off)}$		24	14	ns	
			P-Ch	52	19	-
Fall Time	t _f		N-Ch	26	6	
			P-Ch	7	24	
Source-Drain Reverse Recovery Time	t _{rr}	$I_S = 1.05 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$	N-Ch	27	30	
		$I_S = -1.05 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$	P-Ch	20	20	

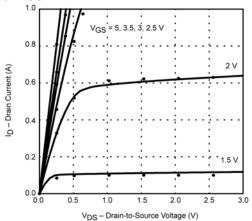
Notes a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2.$ b. Guaranteed by design, not subject to production testing.

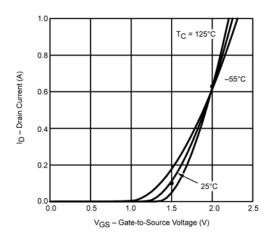


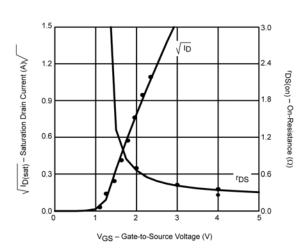
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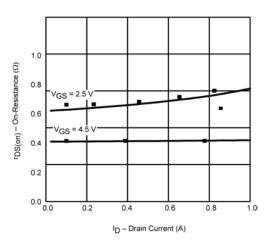
COMPARISON OF MODEL WITH MEASURED DATA (TJ=25°C UNLESS OTHERWISE NOTED)

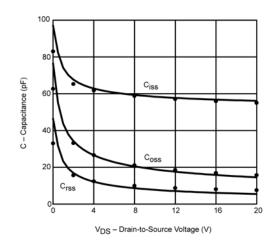
N-Channel MOSFET

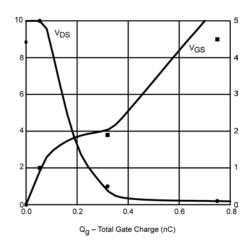












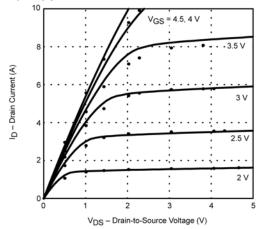
Note: Dots and squares represent measured data

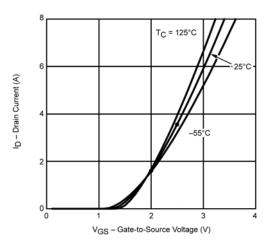
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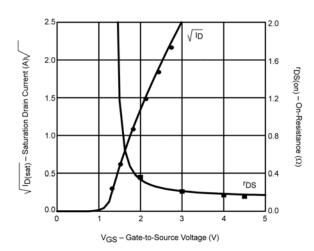
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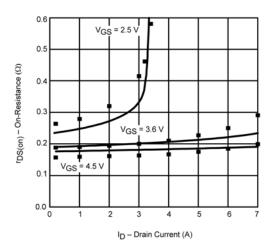
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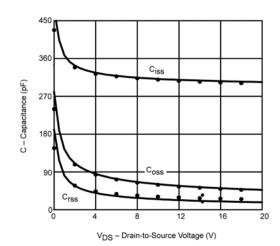
P-Channel MOSFET

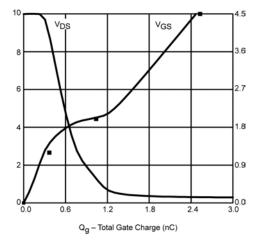












Note: Dots and squares represent measured data.



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